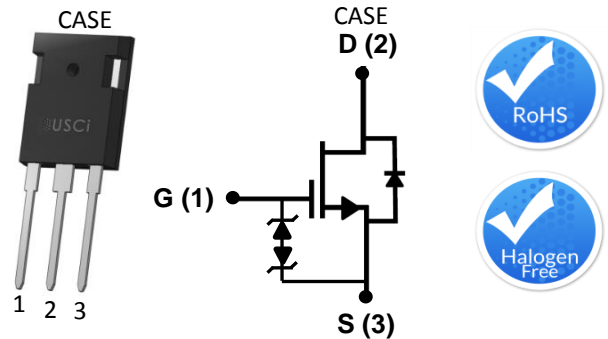


## Description

United Silicon Carbide's cascode products co-package its xJ series high-performance SiC JFETs with a cascode optimized MOSFET to produce the only standard gate drive SiC device in the market today. This series exhibits ultra-low gate charge, but also the best reverse recovery characteristics of any device of similar ratings. These devices are excellent for switching inductive loads, and any application requiring standard gate drive. These devices have built-in zener diodes to protect the gate from electrostatic discharge (ESD).



Part Number	Package	Marking
UJC1220K	TO-247-3L	UJC1220K

## Features

- ◆ Max. on-resistance  $R_{DS(on)max}$  of 220mΩ
- ◆ Standard 12V gate drive
- ◆ Maximum operating temperature of 150°C
- ◆ Excellent reverse recovery
- ◆ Low gate charge
- ◆ Low intrinsic capacitance
- ◆ Gate-source ESD protection
- ◆ RoHS compliant

## Typical Applications

- ◆ EV charging
- ◆ PV inverters
- ◆ Switch mode power supplies
- ◆ Power factor correction modules
- ◆ Motor drives
- ◆ Induction heating

## Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	$V_{DS}$		1200	V
Gate-source voltage	$V_{GS}$	DC	-20 to +20	V
Continuous drain current	$I_D$	$T_C = 25^\circ\text{C}$	11.6	A
		$T_C = 100^\circ\text{C}$	7.7	A
Pulsed drain current <sup>1</sup>	$I_{DM}$	$T_j = 25^\circ\text{C}$	28	A
		$T_j = 150^\circ\text{C}$	18.5	
Short-circuit withstand time <sup>2</sup>	$t_{SC}$	$V_{GS}=15\text{V}, V_{CC}<600\text{V}$	4	μs
Single pulsed avalanche energy <sup>2</sup>	$E_{AS}$	$L=15\text{mH}, I_{AS}=1.76\text{A}$	23.3	mJ
Power dissipation	$P_{tot}$	$T_C = 25^\circ\text{C}$	73.5	W
Maximum junction temperature	$T_{J,max}$		150	°C
Operating and storage temperature	$T_J, T_{STG}$		-55 to 150	°C
Max. lead temperature for soldering, 1/8" from case for 5 Seconds	$T_L$		250	°C

<sup>1</sup> Pulse width  $t_p$  limited by  $T_{j,max}$

<sup>2</sup> Starting  $T_j = 25^\circ\text{C}$

**Electrical Characteristics** ( $T_J = +25^\circ\text{C}$  unless otherwise specified)

**Typical Performance - Static**

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Drain-source breakdown voltage	$BV_{DS}$	$V_{GS}=0V, I_D=1mA$	1200			V
Total drain leakage current	$I_{DSS}$	$V_{DS} = 1200V,$ $V_{GS} = 0V, T_J = 25^\circ\text{C}$		50	250	$\mu\text{A}$
		$V_{DS} = 1200V,$ $V_{GS} = 0V, T_J = 150^\circ\text{C}$		80		
Total gate leakage current	$I_{GSS}$	$V_{DS}=0V, T_J=25^\circ\text{C},$ $V_{GS} = -20V / +20V$		3.5	15	$\mu\text{A}$
Gate-source zener breakdown voltage	$BV_{GSO}$	$I_G=250\mu\text{A}$	$\pm 22$	$\pm 25$	$\pm 29$	V
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS}=12V, I_D=5A,$ $T_J = 25^\circ\text{C}$		180	220	$\text{m}\Omega$
		$V_{GS}=12V, I_D=5A,$ $T_J = 150^\circ\text{C}$		400		
Gate threshold voltage	$V_{G(th)}$	$V_{DS} = 5V, I_D = 10mA$	3.5	4.5	5.5	V
Gate resistance	$R_G$	$f = 1\text{MHz}, \text{open drain}$		5		$\Omega$

**Typical Performance - Reverse Diode**

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Diode continuous forward current	$I_S$	$T_C = 25^\circ\text{C}$			11.6	A
Diode pulse current <sup>1</sup>	$I_{S,pulse}$	$T_C = 25^\circ\text{C}$			28	A
Forward voltage	$V_{FSD}$	$V_{GS} = 0V, I_F = 5A,$ $T_J = 25^\circ\text{C}$		1.6	2	V
		$V_{GS} = 0V, I_F = 5A,$ $T_J = 150^\circ\text{C}$		2.4		
Reverse recovery charge	$Q_{rr}$	$V_R=800V, I_F=7.5A,$ $V_{GS}=0V, R_{G\_EXT}=1.8\Omega$		42		nC
Reverse recovery time	$t_{rr}$	$di/dt=1800A/\mu\text{s},$ $T_J = 25^\circ\text{C}$		33		ns
Reverse recovery charge	$Q_{rr}$	$V_R=800V, I_F=7.5A,$ $V_{GS}=0V, R_{G\_EXT}=1.8\Omega$		53		nC
Reverse recovery time	$t_{rr}$	$di/dt=1800A/\mu\text{s},$ $T_J = 150^\circ\text{C}$		33		ns

**Typical Performance - Dynamic**

Parameter	symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Input capacitance	$C_{iss}$	$V_{DS} = 100V,$ $V_{GS} = 0V,$ $f = 100kHz$		740		pF
Output capacitance	$C_{oss}$			52		
Reverse transfer capacitance	$C_{rss}$			3.5		
Effective output capacitance, energy related	$C_{oss(er)}$	$V_{DS} = 0V$ to 800V, $V_{GS} = 0V$		32		pF
Effective output capacitance, time related	$C_{oss(tr)}$	$V_{DS} = 0V$ to 800V, $V_{GS} = 0V$		49		pF
$C_{oss}$ stored energy	$E_{oss}$	$V_{DS} = 800V,$ $V_{GS} = 0V$		10.2		μJ
Total gate charge	$Q_G$	$V_{DS}=800V, I_D = 7.5A,$ $V_{GS}=0V$ to 12V		20		nC
Gate-drain charge	$Q_{GD}$			6.5		
Gate-source charge	$Q_{GS}$			6.5		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=800V, I_D=7.5A,$ Gate Driver =0V to +12V, $R_{G,EXT} =1.8\Omega$ Inductive Load, FWD: UJ2D1205T $T_J = 25^\circ C$		20		ns
Rise time	$t_r$			12		
Turn-off delay time	$t_{d(off)}$			20		
Fall time	$t_f$			10		
Turn-on energy	$E_{ON}$			126		
Turn-off energy	$E_{OFF}$	$V_{DS}=800V, I_D=7.5A,$ Gate Driver =0V to +12V, $R_{G,EXT} =1.8\Omega$ Inductive Load, FWD: UJ2D1205T $T_J = 150^\circ C$		20		μJ
Total switching energy	$E_{TOTAL}$			146		
Turn-on delay time	$t_{d(on)}$			21		ns
Rise time	$t_r$			15		
Turn-off delay time	$t_{d(off)}$			22		
Fall time	$t_f$			9.5		
Turn-on energy	$E_{ON}$			151		μJ
Turn-off energy	$E_{OFF}$		20			
Total switching energy	$E_{TOTAL}$		171			

**Thermal Characteristics**

Parameter	symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Thermal resistance, junction-to-case	$R_{\theta JC}$			1.3	1.7	°C/W

Typical Performance Diagrams

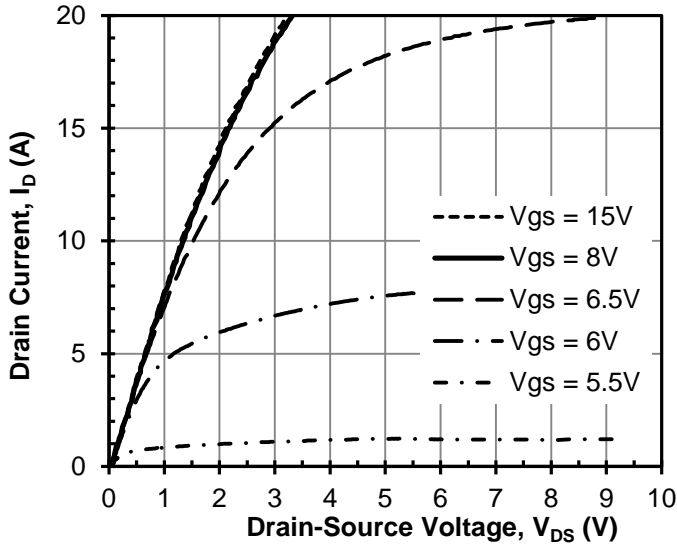


Figure 1 Typical output characteristics at  $T_j = -55^\circ\text{C}$ ,  $t_p < 250 \mu\text{s}$

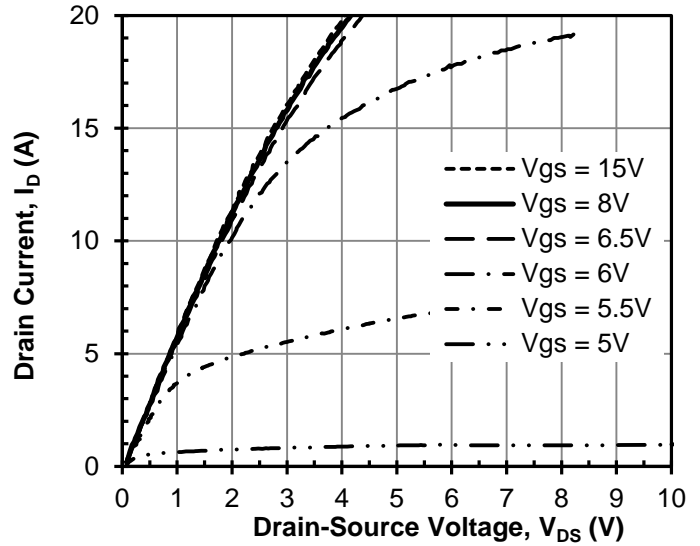


Figure 2 Typical output characteristics at  $T_j = 25^\circ\text{C}$ ,  $t_p < 250 \mu\text{s}$

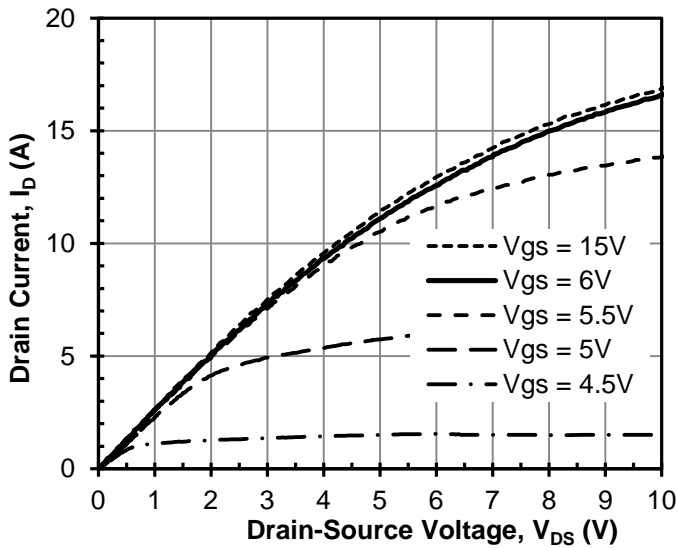


Figure 3 Typical output characteristics at  $T_j = 150^\circ\text{C}$ ,  $t_p < 250 \mu\text{s}$

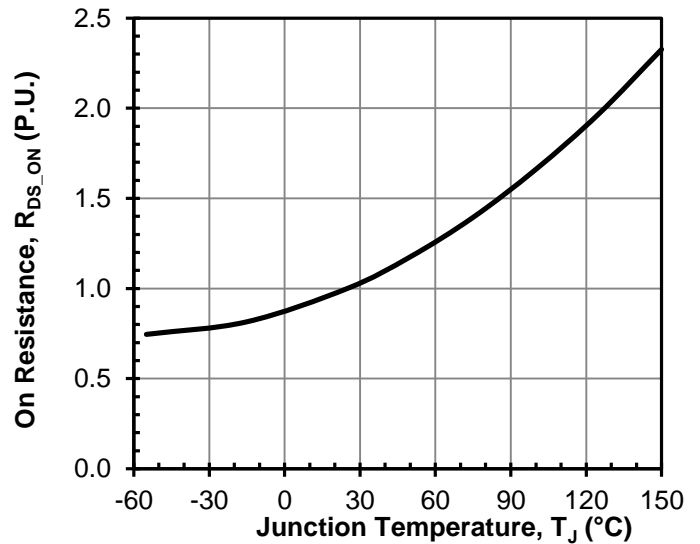


Figure 4 Normalized on-resistance vs. temperature at  $V_{GS} = 12\text{V}$  and  $I_D = 5\text{A}$

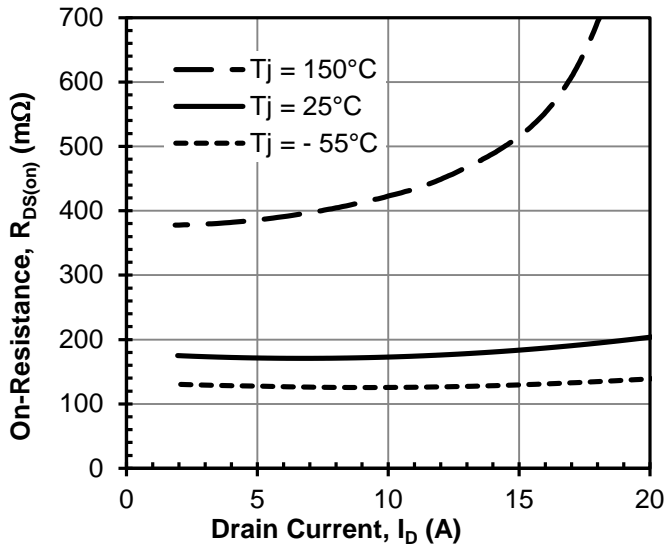


Figure 5 Typical drain-source on-resistance at  $V_{GS} = 12V$

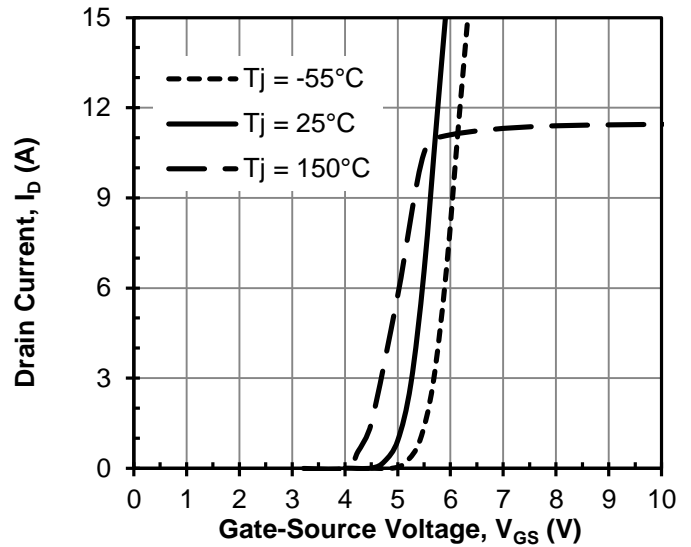


Figure 6 Typical transfer characteristics at  $V_{DS} = 5V$

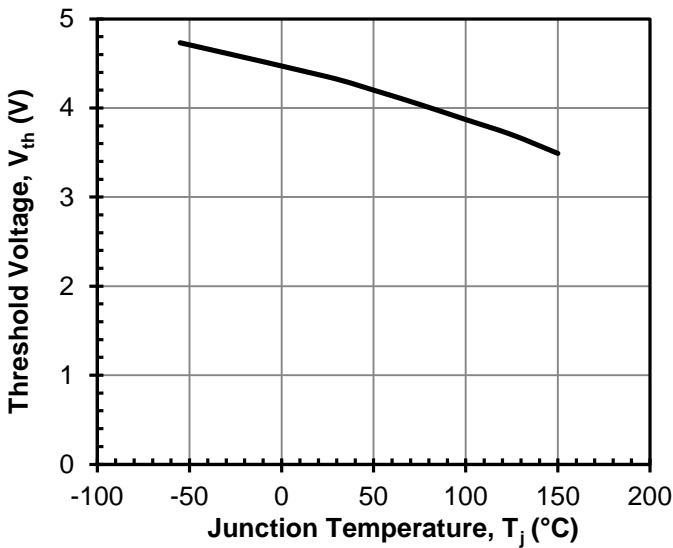


Figure 7 Threshold voltage vs.  $T_j$  at  $V_{DS} = 5V$  and  $I_D = 10mA$

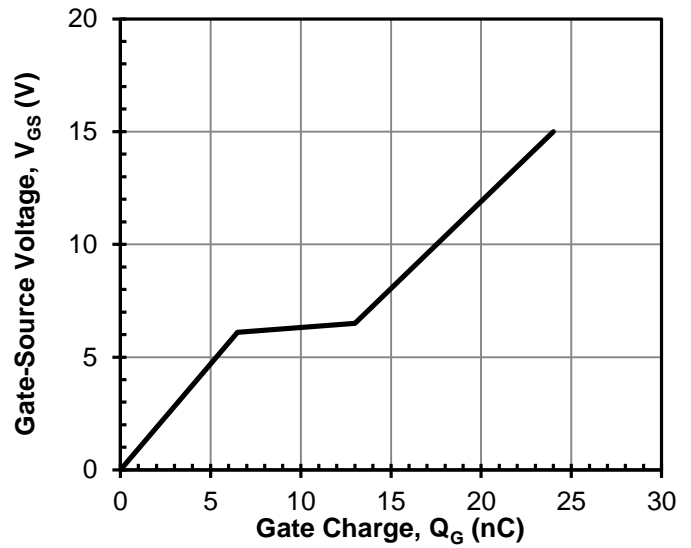


Figure 8 Typical gate charge at  $V_{DS} = 800V$  and  $I_D = 7.5A$

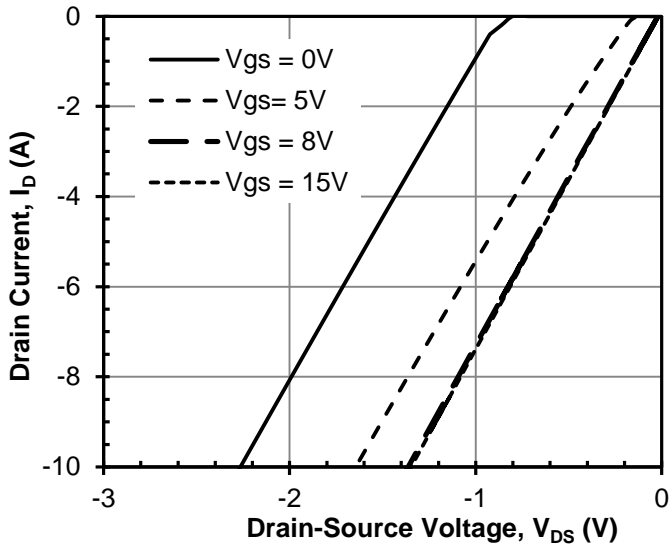


Figure 9 3rd quadrant characteristics at  $T_J = -55^\circ\text{C}$

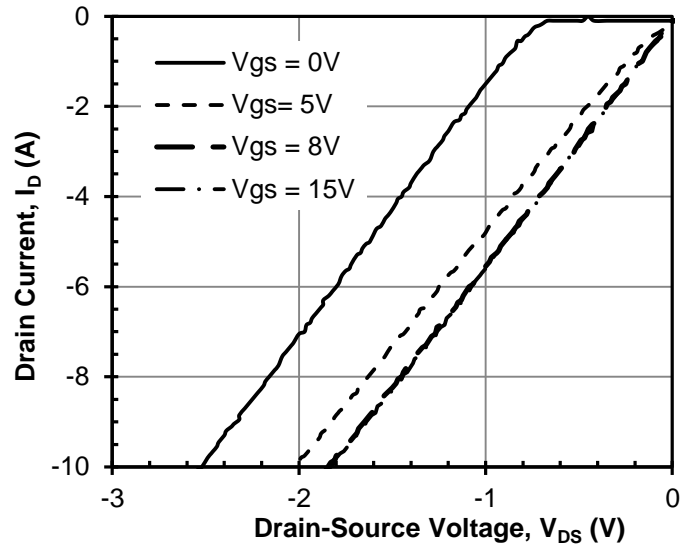


Figure 10 3rd quadrant characteristics at  $T_J = 25^\circ\text{C}$

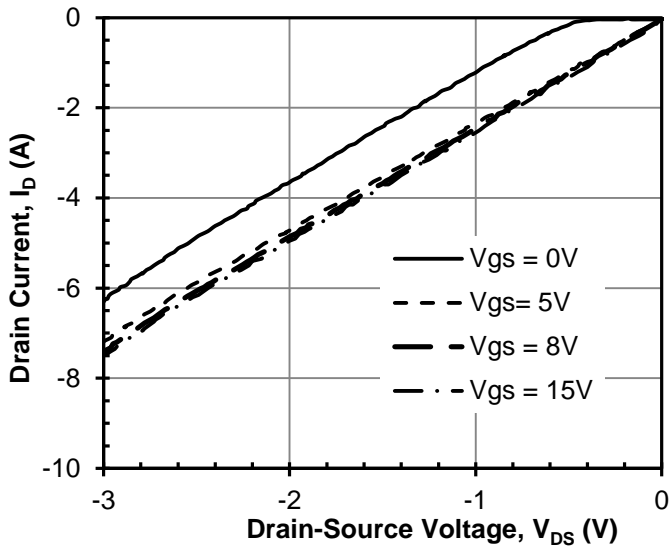


Figure 11 3rd quadrant characteristics at  $T_J = 150^\circ\text{C}$

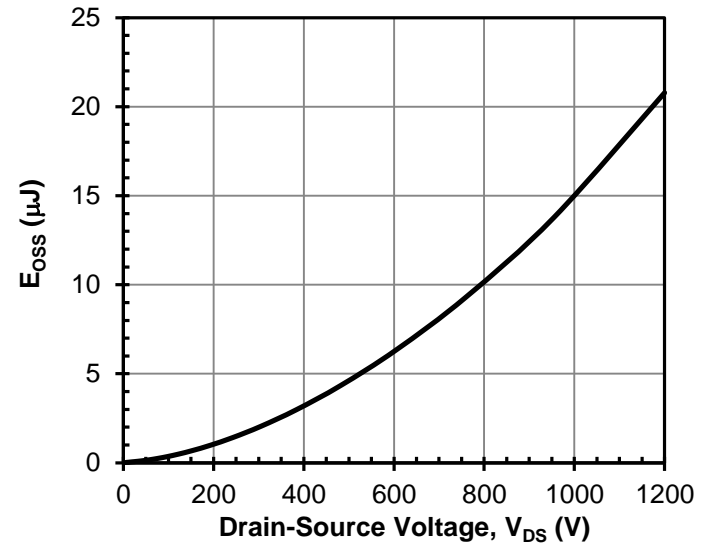


Figure 12 Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0\text{V}$

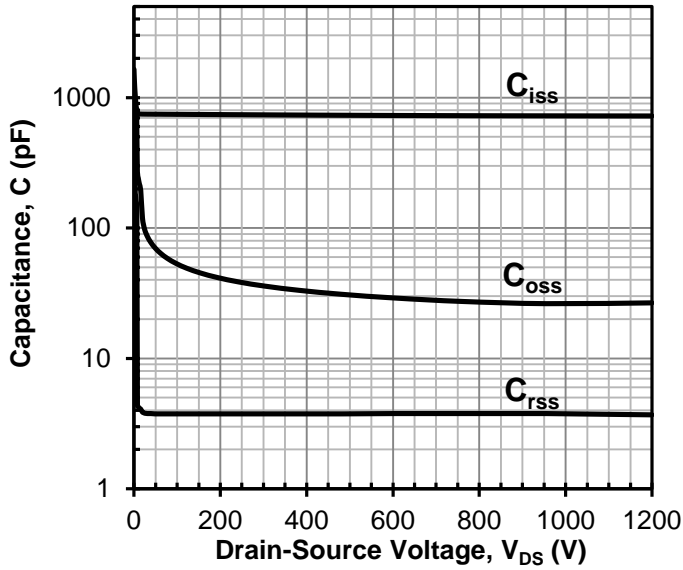


Figure 13 Typical capacitances at 100kHz and  $V_{GS} = 0V$

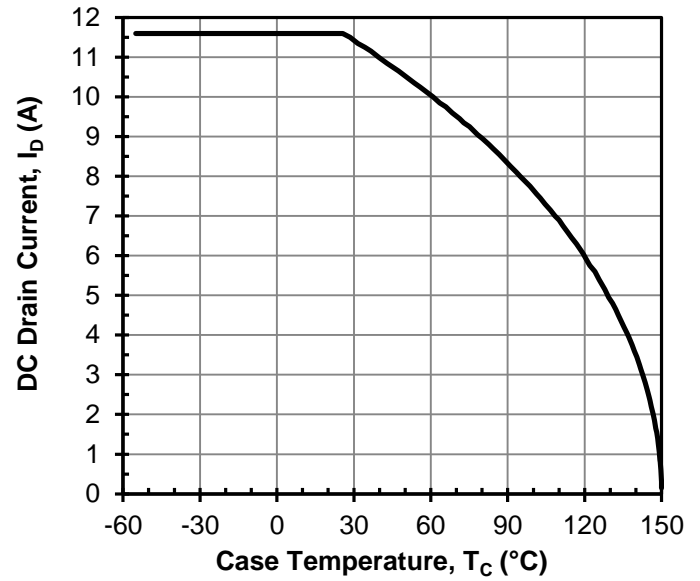


Figure 14 DC drain current derating

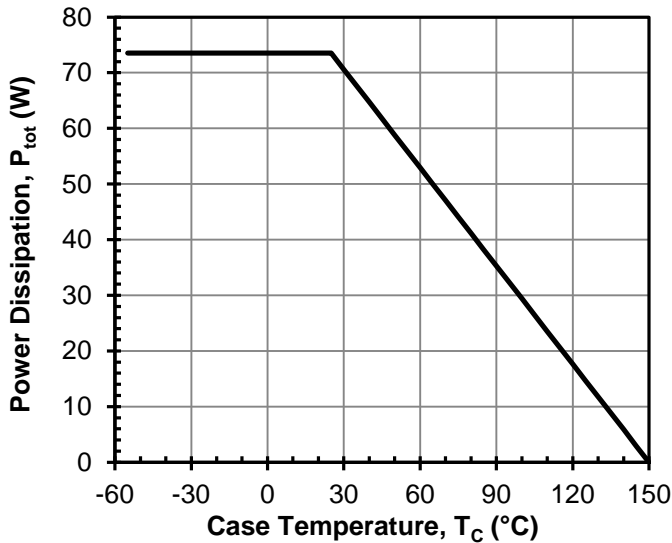


Figure 15 Total power dissipation

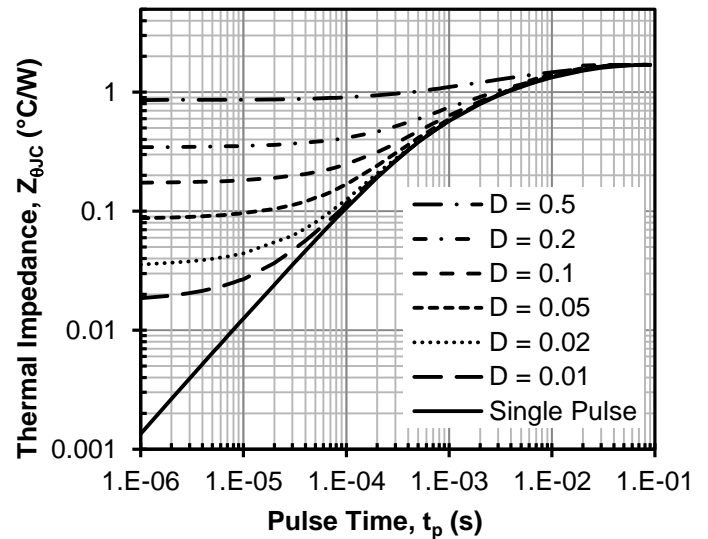


Figure 16 Maximum transient thermal impedance

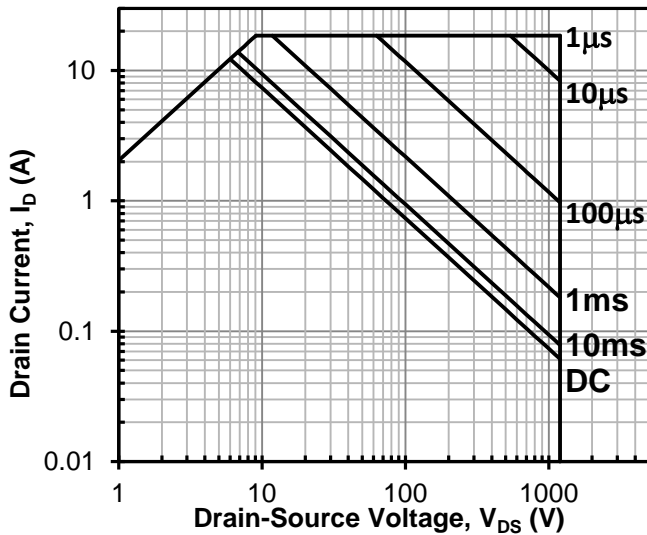


Figure 17 Safe operation area  
 $T_c = 25^\circ\text{C}$ ,  $D = 0$ , Parameter  $t_p$

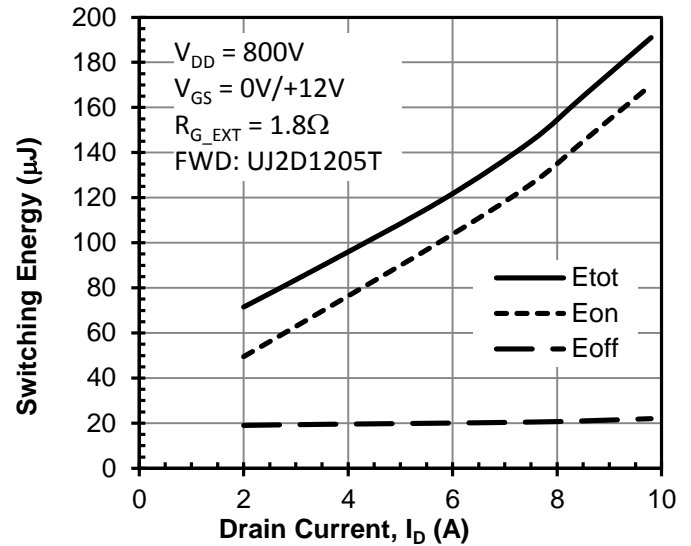


Figure 18 Clamped inductive switching energy vs. drain current at  $T_j = 25^\circ\text{C}$

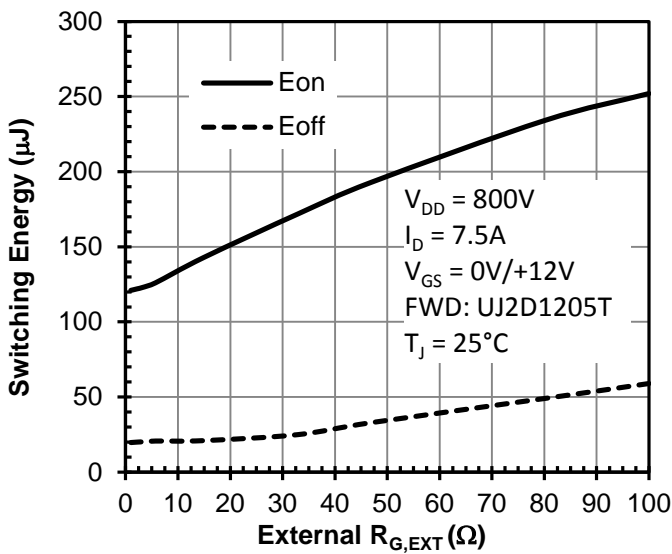
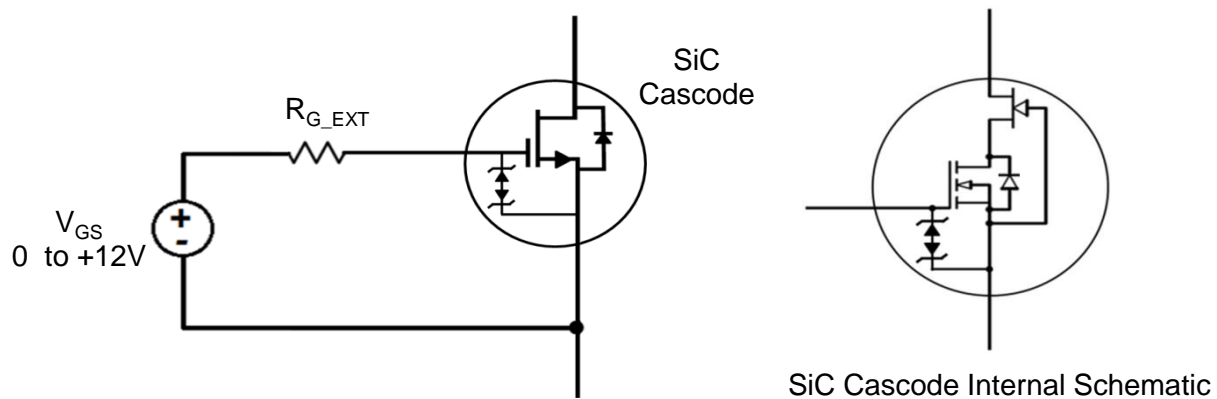


Figure 19 Clamped inductive switching energy vs.  $R_{G\_EXT}$





**Figure 20 Recommended gate drive and internal circuit schematic of SiC cascode**

## Applications Information

SiC cascodes are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series as shown in Figure 21. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_g$ ), and reverse recovery charge ( $Q_{rr}$ ) leading to low conduction and switching losses. The SiC cascodes also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high  $dv/dt$  and  $di/dt$  rates. In particular, separate turn-on and turn-off gate resistors are recommended as shown in Figure 20. For more information on cascode operation, see [www.unitedsic.com](http://www.unitedsic.com).

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